

RF LDMOS Wideband Integrated Power Amplifiers

The MDE6IC7120N/GN wideband integrated circuit is designed with on-chip matching that makes it usable from 728 to 768 MHz. This multi-stage structure is rated for 26 to 32 Volt operation and covers all typical cellular base station modulation formats.

- Typical Doherty Single-Carrier W-CDMA Performance: $V_{DD} = 28$ Volts, $I_{DQ1A} = I_{DQ1B} = 80$ mA, $I_{DQ2A} = 550$ mA, $V_{G2B} = 2.3$ Vdc, $P_{out} = 25$ Watts Avg., IQ Magnitude Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF.

Frequency	G_{ps} (dB)	PAE (%)	Output PAR (dB)	ACPR (dBc)
728 MHz	35.0	42.0	6.2	-39.0
748 MHz	34.4	40.6	6.8	-41.3
768 MHz	33.8	39.1	6.9	-37.3

- Capable of Handling 10:1 VSWR, @ 32 Vdc, 748 MHz, 104 Watts CW Output Power (2 dB Input Overdrive from Rated P_{out}), Designed for Enhanced Ruggedness
- Stable into a 5:1 VSWR. All Spurs Below -60 dBc @ 100 mW to 120 Watts CW P_{out}
- Typical P_{out} @ 1 dB Compression Point $\approx$ 120 Watts CW

Features

- Production Tested in a Symmetrical Doherty Configuration
- 100% PAR Tested for Guaranteed Output Power Capability
- Characterized with Series Equivalent Large-Signal Impedance Parameters and Common Source S-Parameters
- On-Chip Matching (50 Ohm Input, DC Blocked)
- Integrated Quiescent Current Temperature Compensation with Enable/Disable Function (1)
- Integrated ESD Protection
- 225°C Capable Plastic Package
- RoHS Compliant
- In Tape and Reel. R1 Suffix = 500 Units per 44 mm, 13 inch Reel

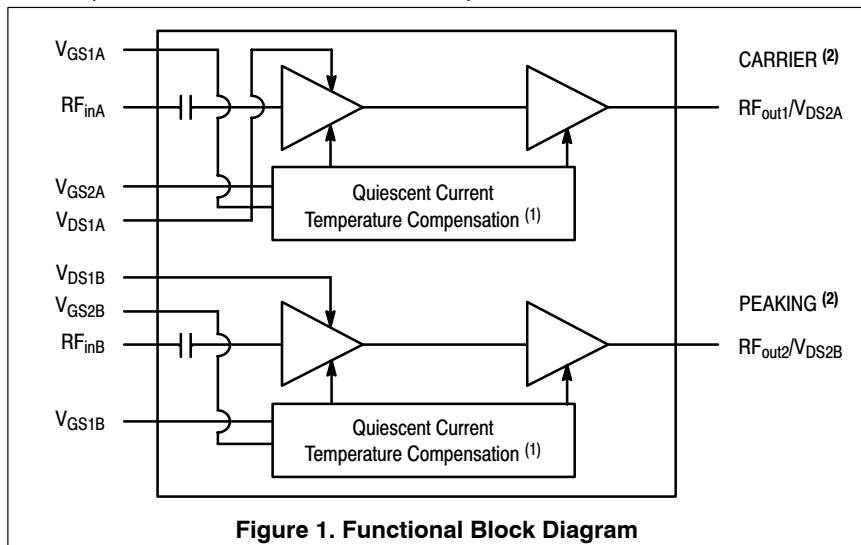


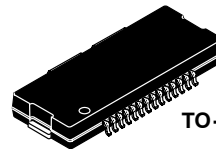
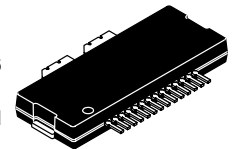
Figure 1. Functional Block Diagram

- Refer to AN1977, Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family and to AN1987, Quiescent Current Control for the RF Integrated Circuit Device Family. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1977 or AN1987.
- Peaking and Carrier orientation is determined by the test fixture design.

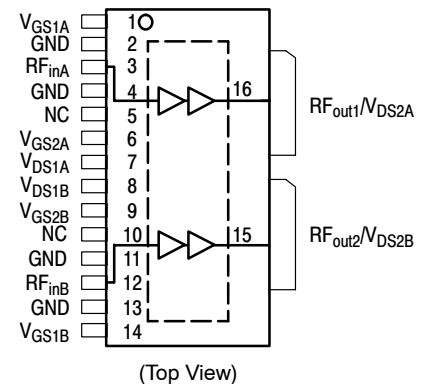
MDE6IC7120NR1
MDE6IC7120GNR1

728-768 MHz, 25 W AVG., 28 V
SINGLE W-CDMA
RF LDMOS WIDEBAND
INTEGRATED POWER AMPLIFIERS

CASE 1866-02
TO-270 WBL-16
PLASTIC
MDE6IC7120NR1



CASE 1867-02
TO-270 WBL-16 GULL
PLASTIC
MDE6IC7120GNR1



Note: Exposed backside of the package is the source terminal for the transistors.

Figure 2. Pin Connections

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	-0.5, +66	Vdc
Gate-Source Voltage	V_{GS}	-0.5, +10	Vdc
Operating Voltage	V_{DD}	32, +0	Vdc
Storage Temperature Range	T_{stg}	-65 to +150	°C
Case Operating Temperature	T_C	150	°C
Operating Junction Temperature (1,2)	T_J	225	°C
Input Power	P_{in}	30	dBm

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (2,3)	Unit
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Final Doherty Application

Thermal Resistance, Junction to Case	$R_{\theta JC}$		°C/W
Case Temperature 81°C, $P_{out} = 28$ W CW			
Stage 1A, 27 Vdc, $I_{DQ1A} = 60$ mA		4.7	
Stage 1B, 27 Vdc, $I_{DQ1B} = 60$ mA		3.7	
Stage 2A, 27 Vdc, $I_{DQ2A} = 550$ mA		0.90	
Stage 2B, 27 Vdc, $V_{G2B} = 2.3$ Vdc		0.76	

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	1B (Minimum)
Machine Model (per EIA/JESD22-A115)	A (Minimum)
Charge Device Model (per JESD22-C101)	III (Minimum)

Table 4. Moisture Sensitivity Level

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD22-A113, IPC/JEDEC J-STD-020	3	260	°C

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

Table 5. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
Stage 1 — Off Characteristics ⁽¹⁾					
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 66\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$)	I_{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 28\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$)	I_{DSS}	—	—	1	μAdc
Gate-Source Leakage Current ($V_{GS} = 1.5\text{ Vdc}$, $V_{DS} = 0\text{ Vdc}$)	I_{GSS}	—	—	1	μAdc
Stage 1 — On Characteristics ⁽¹⁾					
Gate Threshold Voltage ($V_{DS} = 10\text{ Vdc}$, $I_D = 20\text{ }\mu\text{Adc}$)	$V_{GS(th)}$	1	1.7	3	Vdc
Gate Quiescent Voltage ($V_{DS} = 28\text{ Vdc}$, $I_{DQ1A} = I_{DQ1B} = 80\text{ mA}$)	$V_{GS(Q)}$	—	2.8	—	Vdc
Fixture Gate Quiescent Voltage ($V_{DD} = 28\text{ Vdc}$, $I_{DQ1A} = I_{DQ1B} = 80\text{ mA}$, Measured in Functional Test)	$V_{GG(Q)}$	8	11	14	Vdc
Stage 2 — Off Characteristics ⁽¹⁾					
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 66\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$)	I_{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 28\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$)	I_{DSS}	—	—	1	μAdc
Gate-Source Leakage Current ($V_{GS} = 1.5\text{ Vdc}$, $V_{DS} = 0\text{ Vdc}$)	I_{GSS}	—	—	1	μAdc
Stage 2 — On Characteristics ⁽¹⁾					
Gate Threshold Voltage ($V_{DS} = 10\text{ Vdc}$, $I_D = 160\text{ }\mu\text{Adc}$)	$V_{GS(th)}$	1	1.7	3	Vdc
Gate Quiescent Voltage ($V_{DS} = 28\text{ Vdc}$, $I_{DQ2A} = 550\text{ mA}$)	$V_{GS(Q)}$	—	2.8	—	Vdc
Fixture Gate Quiescent Voltage ($V_{DD} = 28\text{ Vdc}$, $I_{DQ2A} = 550\text{ mA}$, Measured in Functional Test)	$V_{GG(Q)}$	6.6	8.8	11.1	Vdc
Drain-Source On-Voltage ($V_{GS} = 10\text{ Vdc}$, $I_D = 407\text{ mA}$)	$V_{DS(on)}$	0.2	0.3	0.8	Vdc
Functional Tests ^(2,3,4) (In Freescale Doherty Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ1A} = I_{DQ1B} = 80\text{ mA}$, $I_{DQ2A} = 550\text{ mA}$, $V_{G2B} = 2.3\text{ Vdc}$, $P_{out} = 25\text{ W Avg.}$, $f = 748\text{ MHz}$, Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ $\pm 5\text{ MHz}$ Offset.					
Power Gain	G_{ps}	32.0	34.4	37.0	dB
Power Added Efficiency	PAE	38.0	40.6	—	%
Output Peak-to-Average Ratio @ 0.01% Probability on CCDF	PAR	6.2	6.8	—	dB
Adjacent Channel Power Ratio	ACPR	—	-41.3	-38.0	dBc
Typical Broadband Performance ⁽³⁾ (In Freescale Doherty Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ1A} = I_{DQ1B} = 80\text{ mA}$, $I_{DQ2A} = 550\text{ mA}$, $V_{G2B} = 2.3\text{ Vdc}$, $P_{out} = 25\text{ W Avg.}$, Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ $\pm 5\text{ MHz}$ Offset.					
Frequency	G_{ps} (dB)	PAE (%)	Output PAR (dB)	ACPR (dBc)	
728 MHz	35.0	42.0	6.2	-39.0	
748 MHz	34.4	40.6	6.8	-41.3	
768 MHz	33.8	39.1	6.9	-37.3	

- Each side of device measured separately.
- Part internally matched both on input and output.
- Measurement made with device in a Symmetrical Doherty configuration.
- Measurement made with device in straight lead configuration before any lead forming operation is applied.

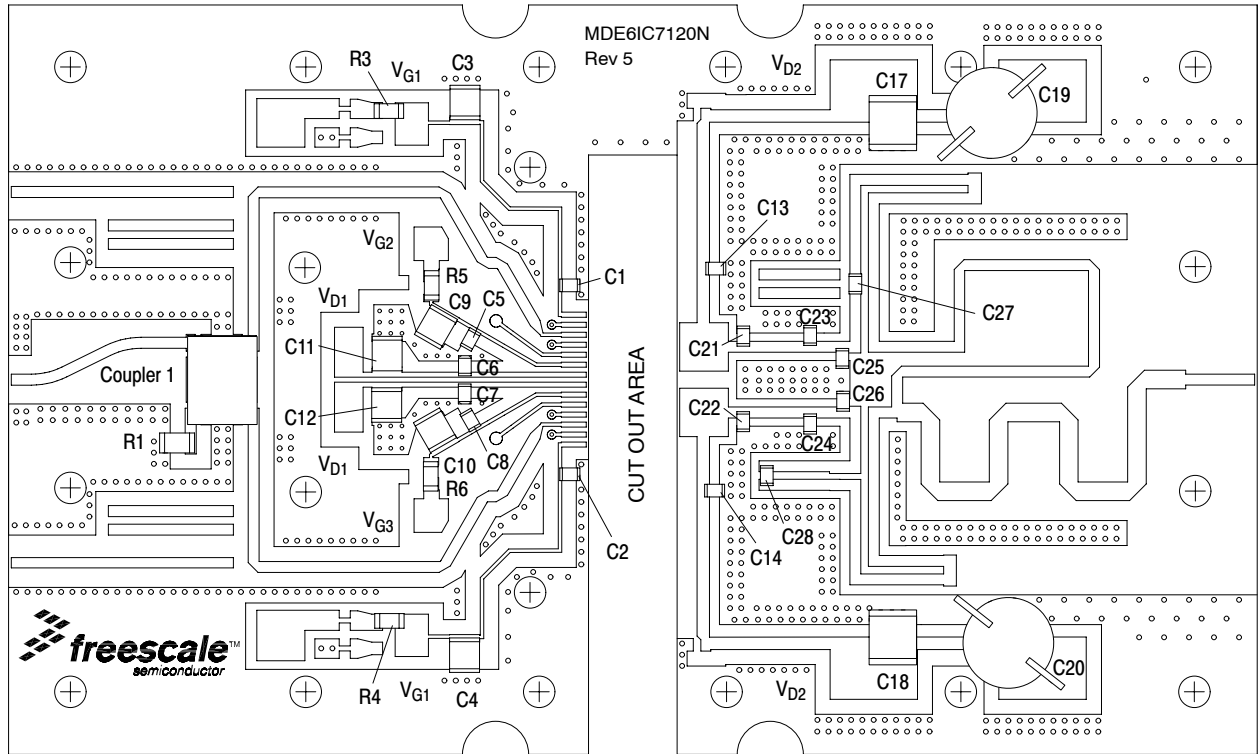
(continued)

Table 5. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted) (continued)

Characteristic	Symbol	Min	Typ	Max	Unit
Typical Performances ⁽¹⁾ (In Freescale Doherty Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ1A} = I_{DQ1B} = 80\text{ mA}$, $I_{DQ2A} = 550\text{ mA}$, $V_{G2B} = 2.3\text{ Vdc}$, 728-768 MHz Bandwidth					
P_{out} @ 1 dB Compression Point, CW	P1dB	—	120	—	W
IMD Symmetry @ 90 W PEP, P_{out} where IMD Third Order Intermodulation $\cong 30\text{ dBc}$ (Delta IMD Third Order Intermodulation between Upper and Lower Sidebands $> 2\text{ dB}$)	IMD _{sym}	—	3	—	MHz
VBW Resonance Point (IMD Third Order Intermodulation Inflection Point)	VBW _{res}	—	65	—	MHz
Quiescent Current Accuracy over Temperature ⁽²⁾ with 4.3 k Ω Gate Feed Resistors (-30 to 85°C)	ΔI_{QT}	— —	0.012 0.031	— —	%
Gain Flatness in 40 MHz Bandwidth @ $P_{out} = 25\text{ W Avg.}$	G_F	—	1.2	—	dB
Gain Variation over Temperature (-30°C to +85°C)	ΔG	—	0.034	—	dB/°C
Output Power Variation over Temperature (-30°C to +85°C)	$\Delta P1\text{dB}$	—	0.005	—	dBm/°C

1. Measurement made with device in a Symmetrical Doherty configuration.

2. Refer to AN1977, *Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family* and to AN1987, *Quiescent Current Control for the RF Integrated Circuit Device Family*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1977 or AN1987.



Note: Component numbers C15, C16 and R2 are not used.

Figure 3. MDE6IC7120NR1(GNR1) Test Circuit Component Layout

Table 6. MDE6IC7120NR1(GNR1) Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1, C2, C5, C6, C7, C8	0.01 μ F, 50 V Chip Capacitors	GCM2195C1H103JA16D	Murata
C3, C4, C9, C10, C11, C12	1.0 μ F, 35 V Chip Capacitors	GRM32RR71H105KA01K	Murata
C13, C14, C27, C28	68 pF Chip Capacitors	ATC600F680JT250XT	ATC
C17, C18	10 μ F, 35 V Chip Capacitors	GRM55DR61H106KA88L	Murata
C19, C20	220 μ F, 50 V Electrolytic Capacitors	EMVY500ADA221MJA0G	Nippon Chemi-Con
C21, C22	18 pF Chip Capacitors	ATC600F180GT250XT	ATC
C23, C24	1.0 pF Chip Capacitors	ATC600F1R0JT250XT	ATC
C25, C26	8.2 pF Chip Capacitors	ATC600F8R2JT250XT	ATC
Coupler 1	50 Ω , 3 dB Hybrid Coupler	GSC268-HYB0750	Soshin
R1	50 Ω , 10 W Termination	RFP-060120A15Z50-2	Anaren
R3, R4, R5, R6	4.3 K Ω , 1/4 W Chip Resistors	CRCW12064K30FKEA	Vishay
PCB	0.020", $\epsilon_r = 3.50$	RO4350B	Rogers

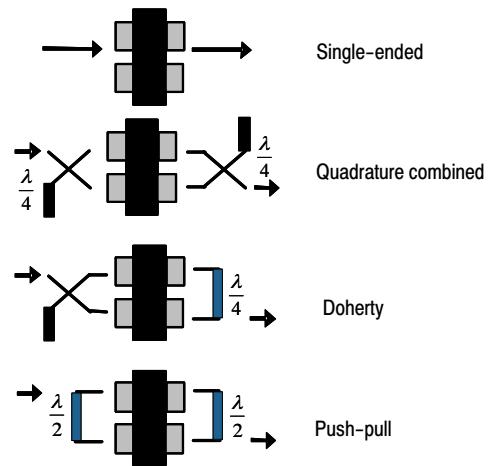


Figure 4. Possible Circuit Topologies

TYPICAL CHARACTERISTICS

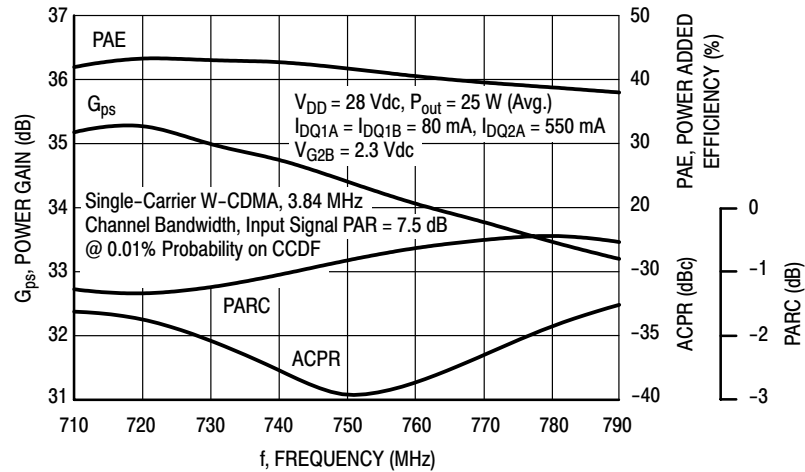


Figure 5. Output Peak-to-Average Ratio Compression (PARC) Broadband Performance @ $P_{out} = 25$ Watts Avg.

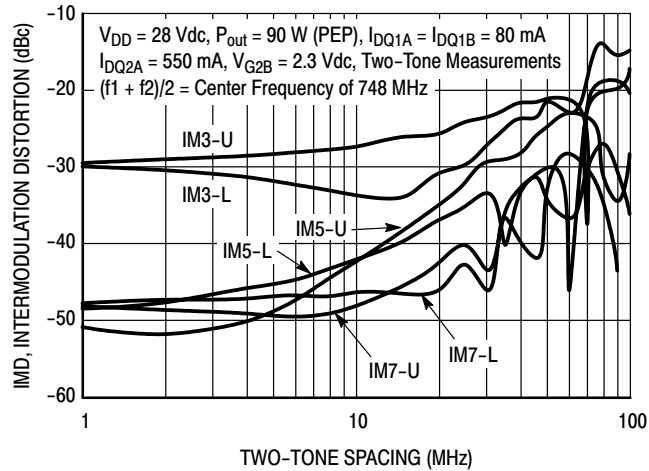


Figure 6. Intermodulation Distortion Products versus Two-Tone Spacing

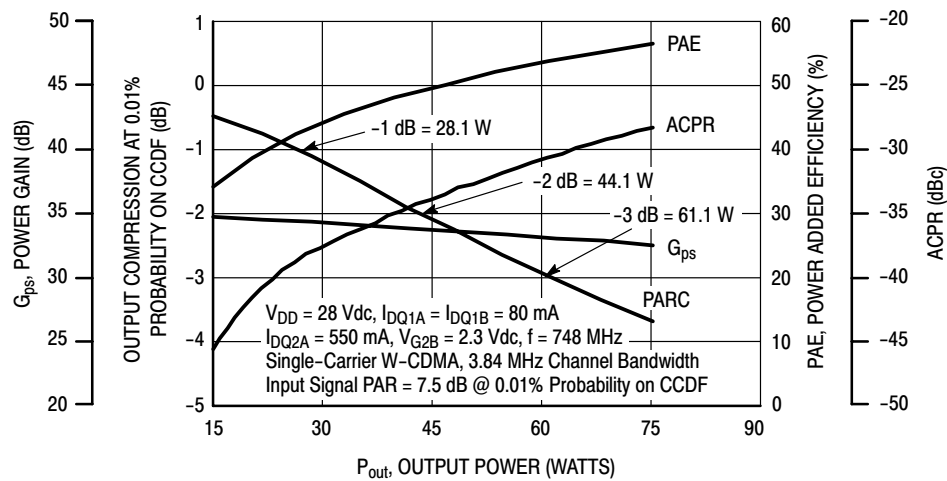


Figure 7. Output Peak-to-Average Ratio Compression (PARC) versus Output Power

TYPICAL CHARACTERISTICS

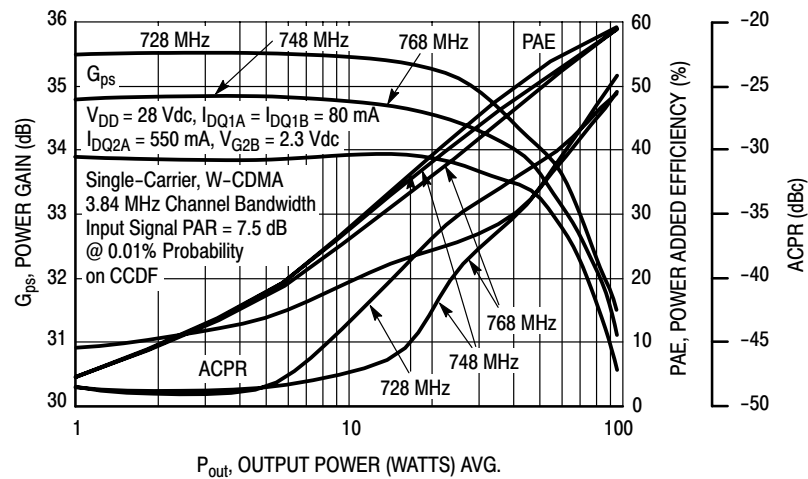


Figure 8. Single-Carrier W-CDMA Power Gain, Power Added Efficiency and ACPR versus Output Power

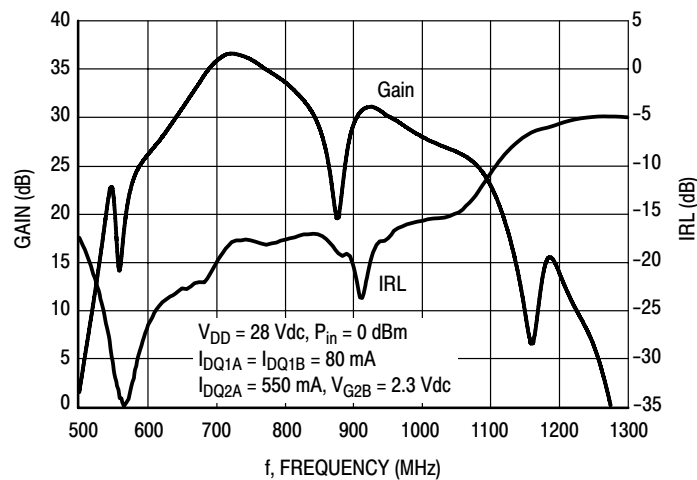


Figure 9. Broadband Frequency Response

W-CDMA TEST SIGNAL

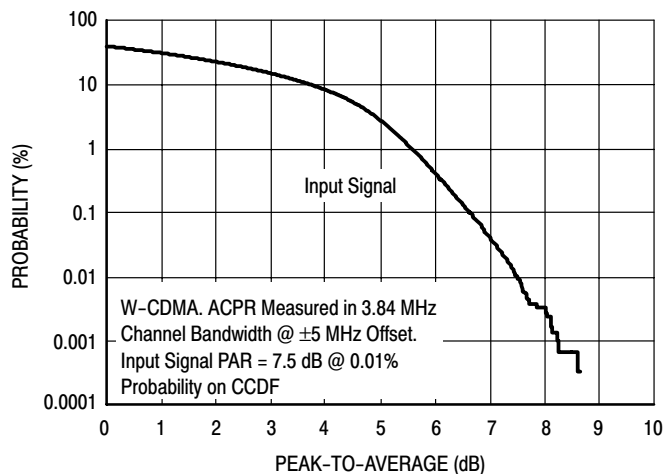


Figure 10. CCDF W-CDMA IQ Magnitude Clipping, Single-Carrier Test Signal

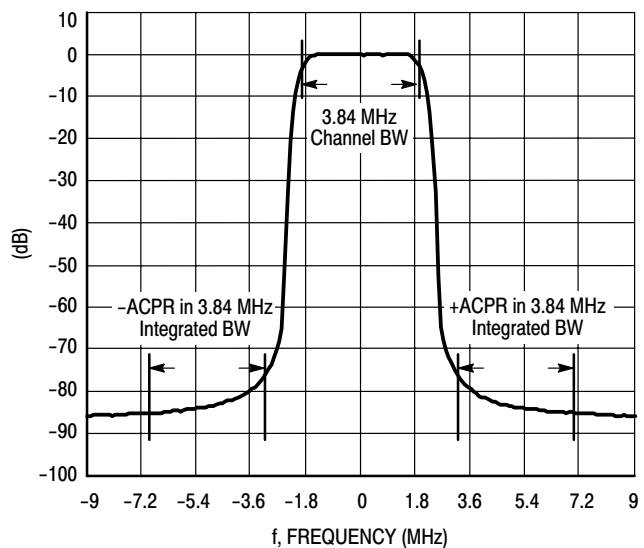


Figure 11. Single-Carrier W-CDMA Spectrum

$V_{DD} = 28 \text{ Vdc}$, $I_{DQ1A} = I_{DQB} = 80 \text{ mA}$, $I_{DQ2A} = 550 \text{ mA}$, $V_{G2B} = 2.3 \text{ Vdc}$, $P_{out} = 25 \text{ W Avg.}$

f MHz	Z_{in} Ω	Z_{load} Ω
710	63.51 - j17.96	2.26 + j2.92
720	63.51 - j16.36	2.43 + j3.05
730	63.27 - j14.61	2.61 + j3.17
740	62.90 - j12.86	2.81 + j3.20
750	62.60 - j11.26	3.04 + j3.21
760	62.50 - j9.83	3.33 + j3.13
770	62.73 - j8.61	3.56 + j2.96
780	63.29 - j7.55	3.73 + j2.75
790	64.11 - j6.70	3.86 + j2.53

Note: Measured with Peaking side open.

Z_{in} = Device input impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

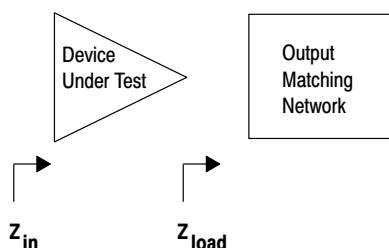


Figure 12. Series Equivalent Input and Load Impedance — Carrier Side

$V_{DD} = 28 \text{ Vdc}$, $I_{DQ1A} = I_{DQB} = 80 \text{ mA}$, $I_{DQ2A} = 550 \text{ mA}$, $V_{G2B} = 2.3 \text{ Vdc}$, $P_{out} = 25 \text{ W Avg.}$

f MHz	Z_{in} Ω	Z_{load} Ω
710	63.51 - j17.96	1.58 - j0.62
720	63.51 - j16.36	1.35 - j0.33
730	63.27 - j14.61	1.16 - j0.05
740	62.90 - j12.86	0.95 + j0.19
750	62.60 - j11.26	0.79 + j0.44
760	62.50 - j9.83	0.68 + j0.66
770	62.73 - j8.61	0.56 + j0.87
780	63.29 - j7.55	0.38 + j1.15
790	64.11 - j6.70	0.30 + j1.46

Note: Measured with Carrier side open.

Z_{in} = Device input impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

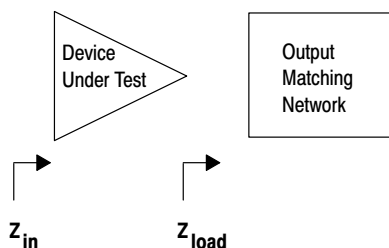
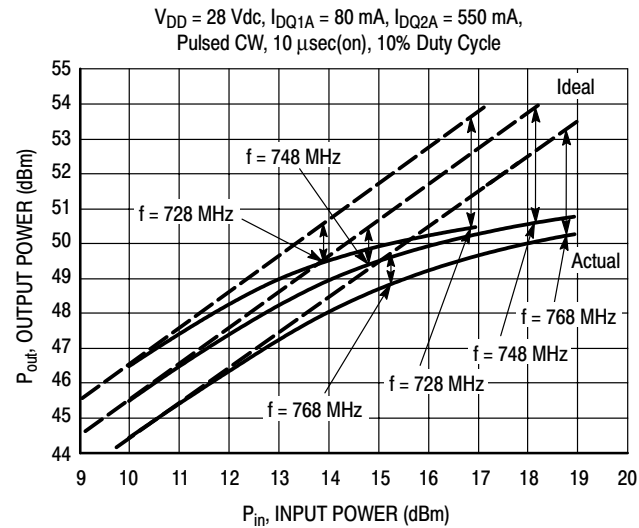


Figure 13. Series Equivalent Input and Load Impedance — Peaking Side

ALTERNATIVE PEAK TUNE LOAD PULL CHARACTERISTICS



f (MHz)	P1dB		P3dB	
	Watts	dBm	Watts	dBm
728	89	49.5	110	50.4
748	87	49.4	115	50.6
768	78	48.9	105	50.2

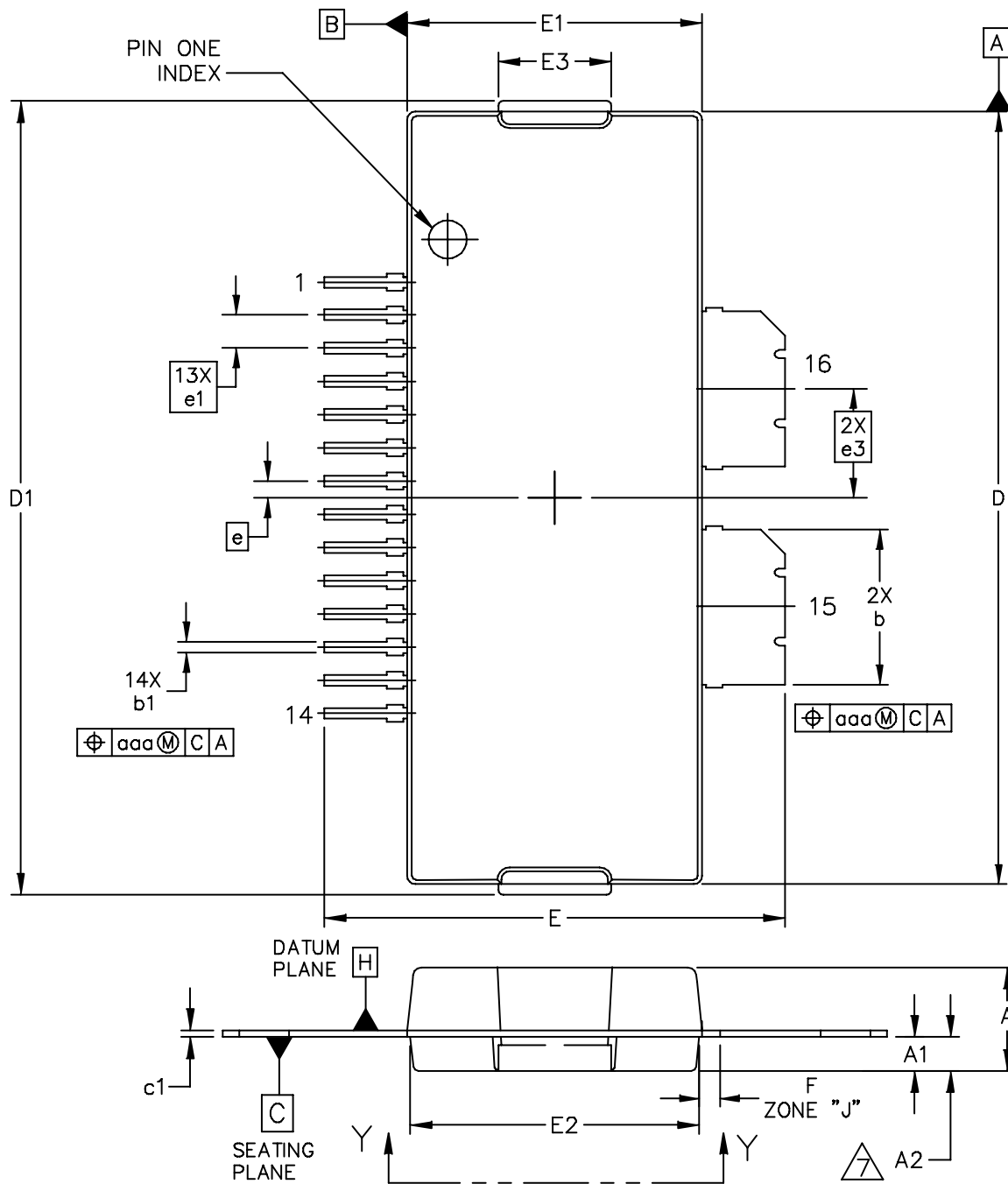
Test Impedances per Compression Level

f (MHz)		Z_{source} Ω	Z_{load} Ω
728	P1dB	$50.23 - j0.14$	$1.88 + j0.60$
748	P1dB	$50.23 + j1.83$	$1.92 + j0.10$
768	P1dB	$48.78 - j1.26$	$1.25 + j0.19$

Figure 14. Pulsed CW Output Power
versus Input Power @ 28 V

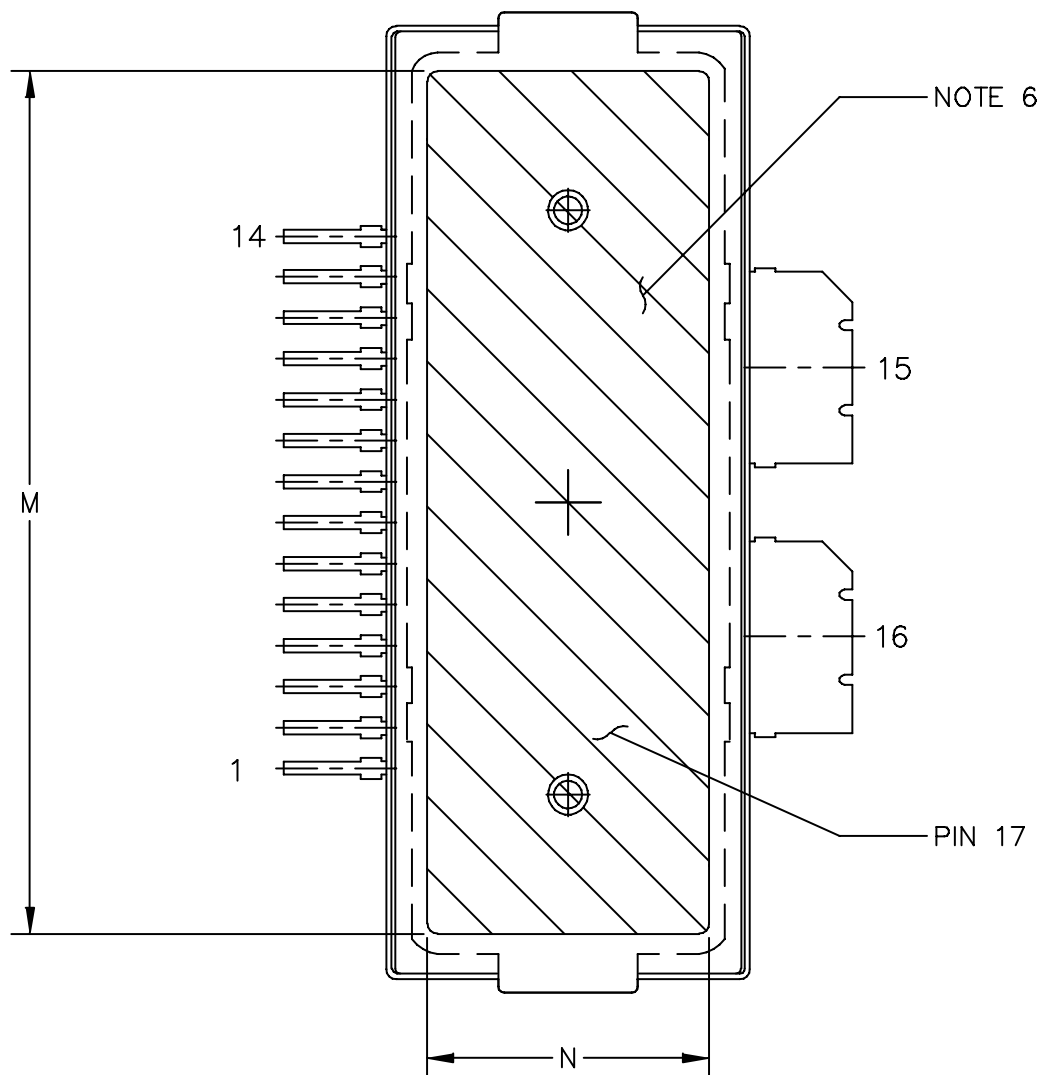
NOTE: Measurement made on the Class AB, carrier side of the device.

PACKAGE DIMENSIONS



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TITLE: TO-270 WIDE BODY LONG, 16 LEAD, PLASTIC		DOCUMENT NO: 98ASA10739D		REV: A	
		CASE NUMBER: 1866-02		02 AUG 2007	
		STANDARD: NON-JEDEC			

MDE6IC7120NR1 MDE6IC7120GNR1



VIEW Y-Y

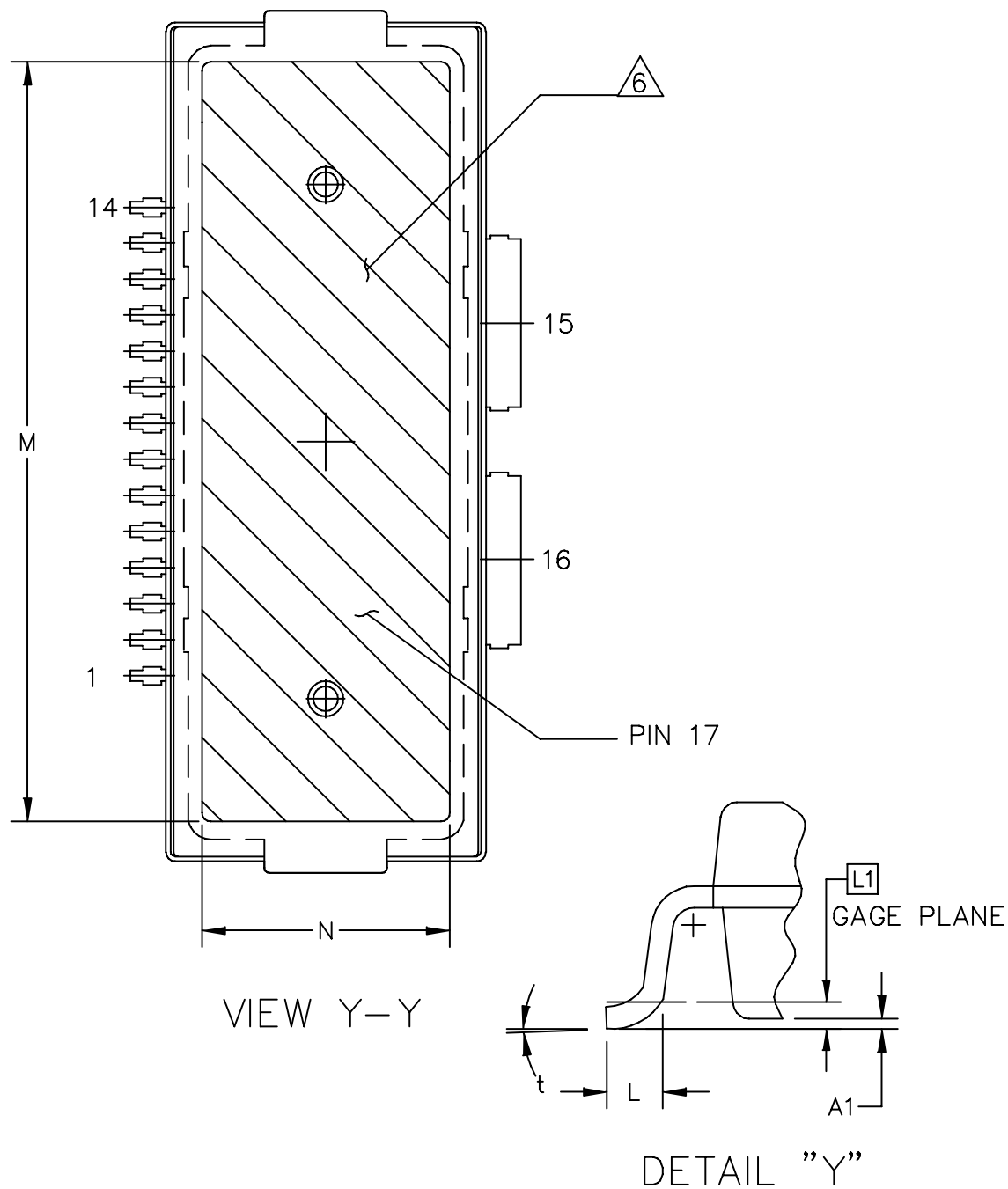
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TITLE: TO-270 WIDE BODY LONG, 16 LEAD, PLASTIC		DOCUMENT NO: 98ASA10739D	REV: A
		CASE NUMBER: 1866-02	02 AUG 2007
		STANDARD: NON-JEDEC	

NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE -H- IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 (0.15) PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
5. DIMENSIONS "b" AND "b1" DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 (0.13) TOTAL IN EXCESS OF THE "b" AND "b1" DIMENSIONS AT MAXIMUM MATERIAL CONDITION.
6. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG.
7. DIM A2 APPLIES WITHIN ZONE "J" ONLY.

INCH			MILLIMETER		INCH			MILLIMETER	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
A	.122	.128	3.10	3.25	M	.800	----	20.32	----
A1	.039	.043	0.96	1.12	N	.270	----	6.86	----
A2	.040	.042	1.02	1.07	b	.184	.190	4.67	4.83
D	.928	.932	23.57	23.67	b1	.010	.016	0.25	0.41
D1	.954	.958	24.23	24.33	c1	.007	.011	0.18	0.28
E	.551	.559	14.00	14.20	e	.020 BSC		0.51 BSC	
E1	.353	.357	8.97	9.07	e1	.040 BSC		1.02 BSC	
E2	.346	.350	8.79	8.89	e3	.131 BSC		3.33 BSC	
E3	.132	.140	3.35	3.56					
F	.025 BSC		0.64 BSC		aaa	.004		0.10	

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TITLE: TO-270 WIDE BODY LONG, 16 LEAD, PLASTIC				DOCUMENT NO: 98ASA10739D		REV: A
				CASE NUMBER: 1866-02		02 AUG 2007
				STANDARD: NON-JEDEC		



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TITLE: TO-270 WIDE BODY LONG, 16 LEAD, GULL WING PLASTIC		DOCUMENT NO: 98ASA10740D		REV: A	
		CASE NUMBER: 1867-02		02 AUG 2007	
		STANDARD: NON-JEDEC			

MDE6IC7120NR1 MDE6IC7120GNR1

NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M–1994.
3. DATUM PLANE H IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 PER SIDE. DIMENSIONS DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE H.
5. DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 TOTAL IN EXCESS OF THE DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG.

INCH		MILLIMETER		INCH		MILLIMETER	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX
A	.122	.128	3.10	3.25	b	.184	.190
A1	.001	.004	0.02	0.10	b1	.010	.016
A2	.125	.131	3.18	3.33	c1	.007	.011
D	.928	.932	23.57	23.67	e	.020 BSC	0.51 BSC
D1	.954	.958	24.23	24.33	e1	.040 BSC	1.02 BSC
E	.429	.437	10.9	11.1	e2	.131 BSC	3.33 BSC
E1	.353	.357	8.97	9.07	t	2°	8°
E2	.346	.350	8.79	8.89	aaa	.004	0.10
E3	.132	.140	3.35	3.56			
L	.018	.024	0.46	0.61			
L1	.01 BSC		0.25 BSC				
M	.800	----	20.32	----			
N	.270	----	6.86	----			
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TITLE: TO-270 WIDE BODY LONG, 16 LEAD, GULL WING PLASTIC					DOCUMENT NO: 98ASA10740D		REV: A
					CASE NUMBER: 1867-02		02 AUG 2007
					STANDARD: NON-JEDEC		

PRODUCT DOCUMENTATION, TOOLS AND SOFTWARE

Refer to the following documents to aid your design process.

Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers
- AN1977: Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family
- AN1987: Quiescent Current Control for the RF Integrated Circuit Device Family

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

For Software and Tools, do a Part Number search at <http://www.freescale.com>, and select the “Part Number” link. Go to the Software & Tools tab on the part’s Product Summary page to download the respective tool.

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Oct. 2009	• Initial Release of Data Sheet

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